

Replaced by MRF5S9100NR1/NBR1. There are no form, fit or function changes with this part replacement. N suffix added to part number to indicate transition to lead-free terminations.

## RF Power Field Effect Transistors

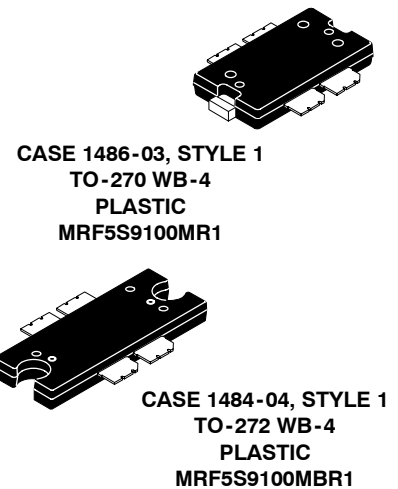
### N-Channel Enhancement-Mode Lateral MOSFETs

Designed for broadband commercial and industrial applications with frequencies up to 1000 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 26 volt base station equipment.

- Typical Single-Carrier N-CDMA Performance @ 880 MHz,  $V_{DD} = 26$  Volts,  $I_{DQ} = 950$  mA,  $P_{out} = 20$  Watts Avg., IS-95 CDMA (Pilot, Sync, Paging, Traffic Codes 8 Through 13) Channel Bandwidth = 1.2288 MHz. PAR = 9.8 dB @ 0.01% Probability on CCDF.  
 Power Gain — 19.5 dB  
 Drain Efficiency — 28%  
 ACPR @ 750 kHz Offset — -46.8 dBc @ 30 kHz Bandwidth
- Capable of Handling 10:1 VSWR, @ 26 Vdc, 880 MHz, 100 Watts CW Output Power
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32  $V_{DD}$  Operation
- Integrated ESD Protection
- 200°C Capable Plastic Package
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel.

**MRF5S9100MR1**  
**MRF5S9100MBR1**

**880 MHz, 20 W AVG., 26 V**  
**SINGLE N-CDMA**  
**LATERAL N-CHANNEL**  
**RF POWER MOSFETs**



ARCHIVE INFORMATION

ARCHIVE INFORMATION

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	- 0.5, +68	Vdc
Gate-Source Voltage	$V_{GS}$	- 0.5, +15	Vdc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	$P_D$	336 1.92	W W/°C
Storage Temperature Range	$T_{stg}$	- 65 to +150	°C
Operating Junction Temperature	$T_J$	200	°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 80°C, 20 W CW	$R_{\theta JC}$	0.52	°C/W

1. MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**NOTE - CAUTION** - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

**Table 3. ESD Protection Characteristics**

Test Conditions	Class
Human Body Model (per JESD22-A114)	1C (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

**Table 4. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD 22-A113, IPC/JEDEC J-STD-020	3	260	°C

**Table 5. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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**Off Characteristics**

Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 68\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 26\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	1	$\mu\text{Adc}$
Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$

**On Characteristics**

Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 400\ \mu\text{A}$ )	$V_{GS(th)}$	2	2.8	3.5	Vdc
Gate Quiescent Voltage ( $V_{DS} = 26\text{ Vdc}$ , $I_D = 950\text{ mAdc}$ )	$V_{GS(Q)}$	—	3.7	—	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 2.0\text{ Adc}$ )	$V_{DS(on)}$	—	0.21	0.3	Vdc
Forward Transconductance ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 6\text{ Adc}$ )	$g_{fs}$	—	7	—	S

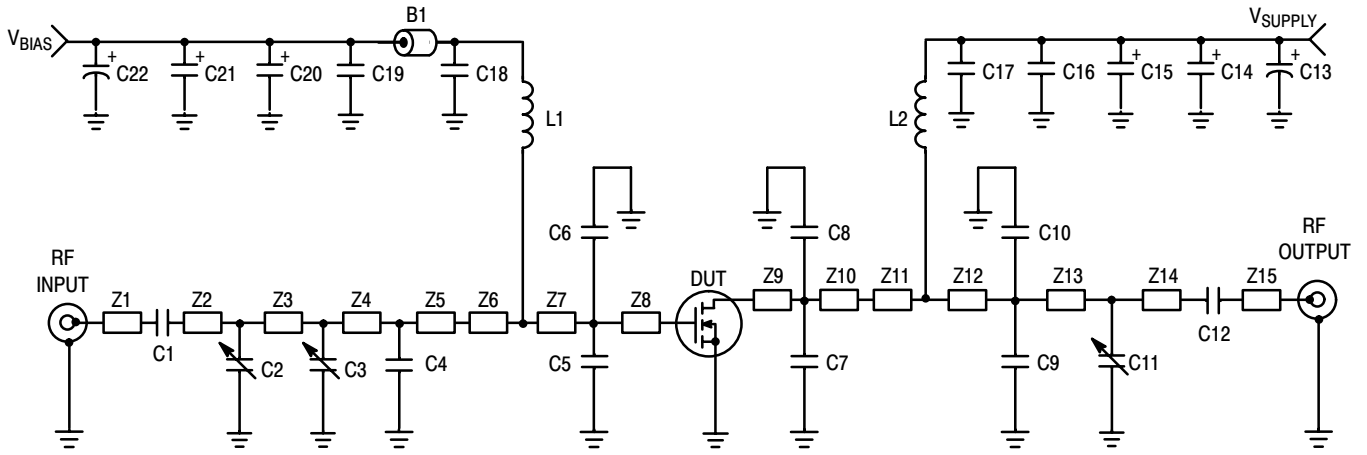
**Dynamic Characteristics** <sup>(1)</sup>

Output Capacitance ( $V_{DS} = 26\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{OSS}$	—	70	—	pF
Reverse Transfer Capacitance ( $V_{DS} = 26\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{rSS}$	—	2.2	—	pF

**Functional Tests** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 26\text{ Vdc}$ ,  $I_{DQ} = 950\text{ mA}$ ,  $P_{out} = 20\text{ W Avg.}$  N-CDMA,  $f = 880\text{ MHz}$ , Single-Carrier N-CDMA, 1.2288 MHz Channel Bandwidth Carrier. ACPR measured in 30 kHz Bandwidth @  $\pm 750\text{ kHz}$  Offset. PAR = 9.8 dB @ 0.01% Probability on CCDF

Power Gain	$G_{ps}$	18	19.5	—	dB
Drain Efficiency	$\eta_D$	26	28	—	%
Adjacent Channel Power Ratio	ACPR	—	-46.8	-45	dBc
Input Return Loss	IRL	—	-19	-9	dB

1. Part is internally input matched.

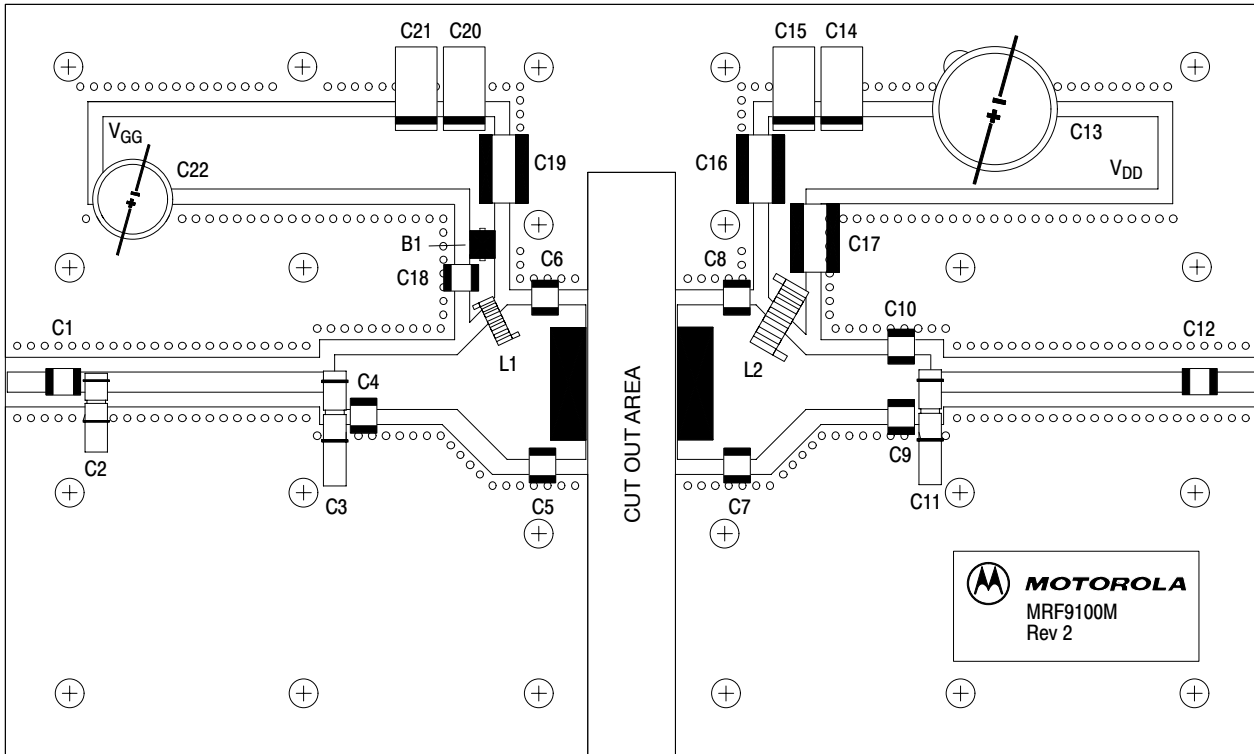


Z1, Z15	0.200" x 0.080" Microstrip	Z8	0.163" x 0.620" Microstrip
Z2	0.105" x 0.080" Microstrip	Z9	0.238" x 0.620" Microstrip
Z3	0.954" x 0.080" Microstrip	Z10	0.077" x 0.620" Microstrip
Z4	0.115" x 0.220" Microstrip	Z12	0.381" x 0.220" Microstrip
Z5	0.375" x 0.220" Microstrip	Z13	0.114" x 0.220" Microstrip
Z6, Z11	0.200" x 0.220" x 0.620" Taper	Z14	1.052" x 0.080" Microstrip
Z7	0.152" x 0.620" Microstrip	PCB	Arlon GX0300, 0.030", $\epsilon_r = 2.55$

**Figure 1. MRF5S9100MR1 (MBR1) Test Circuit Schematic**

**Table 6. MRF5S9100MR1 (MBR1) Test Circuit Component Designations and Values**

Part	Description	Part Number	Manufacturer
B1	Ferrite Bead, Surface Mount	2743019447	Fair-Rite
C1, C12, C18	18 pF Chip Capacitors	100B180JP 500X	ATC
C2	0.6-4.5 pF Variable Capacitor, Gigatrim	27271SL	Johanson Dielectrics
C3, C11	0.8-8.0 pF Variable Capacitors, Gigatrim	27291SL	Johanson Dielectrics
C4	6.2 pF Chip Capacitor	100B6R2JP 500X	ATC
C5, C6	12 pF Chip Capacitors	100B120JP 500X	ATC
C7, C8	11 pF Chip Capacitors	100B110JP 500X	ATC
C9, C10	5.1 pF Chip Capacitors	100B5R1JP 500X	ATC
C13	470 $\mu$ F, 63 V Electrolytic Capacitor	NACZF471M63V	Nippon
C14, C15	22 $\mu$ F, 50 V Tantalum Capacitors	T491X226K035AS	Kemet
C16, C17, C19	0.56 $\mu$ F, 50 V Chip Capacitors	C1825C564J5GAC	Kemet
C20, C21	47 $\mu$ F, 16 V Tantalum Capacitors	T491D4T6K016AS	Kemet
C22	100 $\mu$ F, 50 V Electrolytic Capacitor	515D107M050BB6A	Multicomp
L1	7.15 nH Inductor	1606-7	CoilCraft
L2	22 nH Inductor	B07T-5	CoilCraft



Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

**Figure 2. MRF5S9100MR1(MBR1) Test Circuit Component Layout**

TYPICAL CHARACTERISTICS

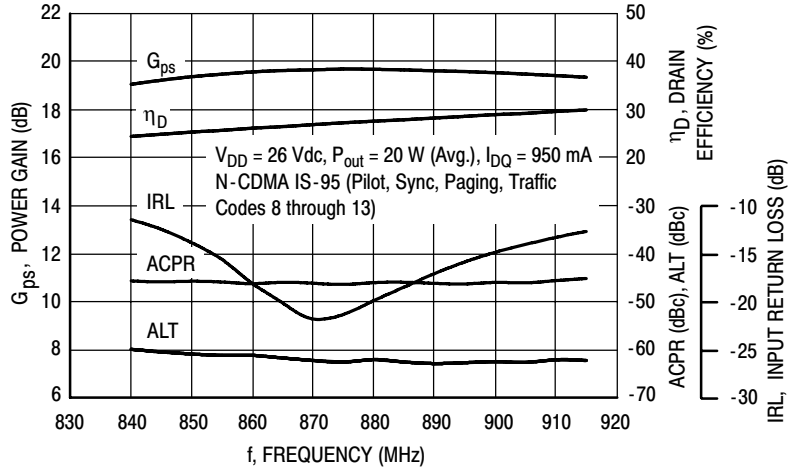


Figure 3. IS-95 Broadband Performance @  $P_{out} = 20$  Watts Avg.

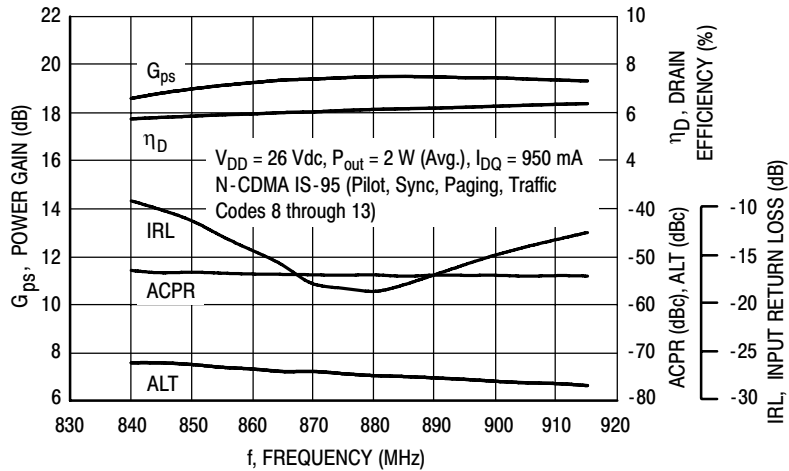


Figure 4. IS-95 Broadband Performance @  $P_{out} = 2$  Watts Avg.

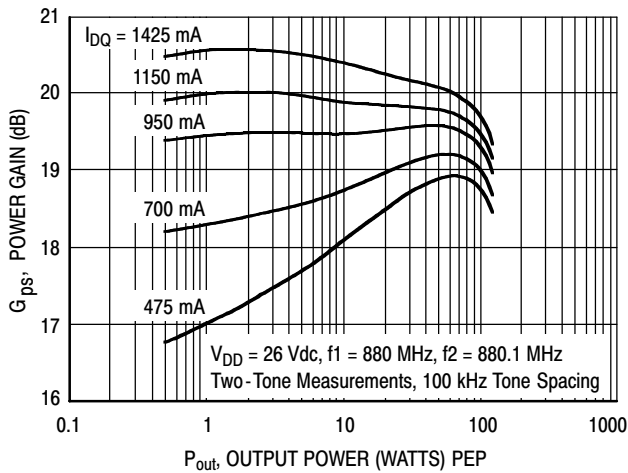


Figure 5. Two-Tone Power Gain versus Output Power

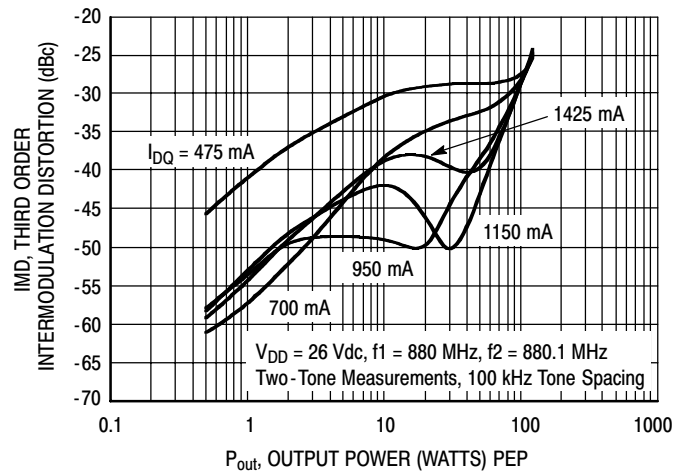


Figure 6. Third Order Intermodulation Distortion versus Output Power

## TYPICAL CHARACTERISTICS

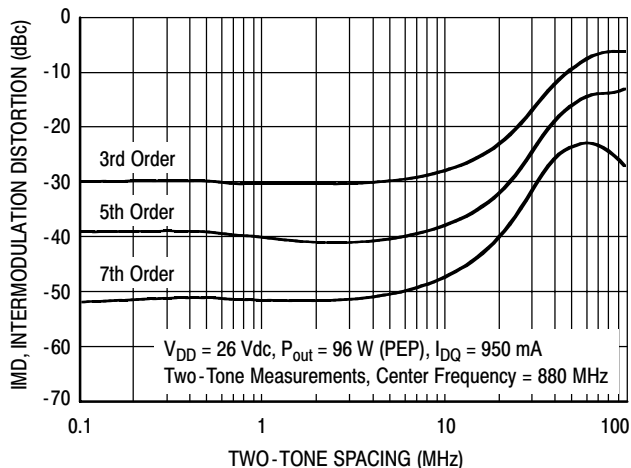


Figure 7. Intermodulation Distortion Products versus Tone Spacing

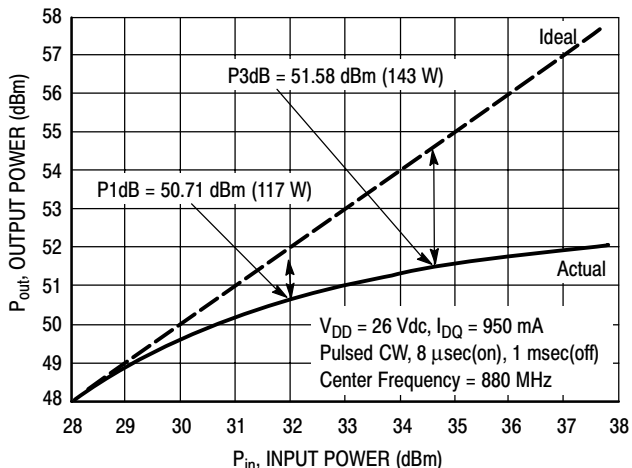


Figure 8. Pulse CW Output Power versus Input Power

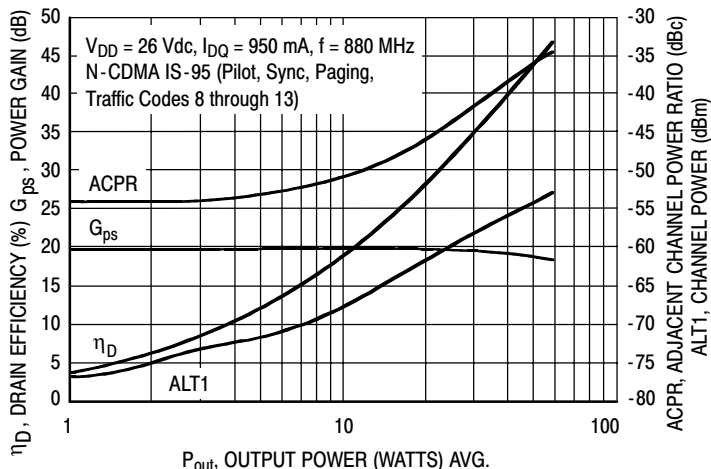


Figure 9. Single-Carrier N-CDMA ACPR, Power Gain, Efficiency and ALT1 versus Output Power

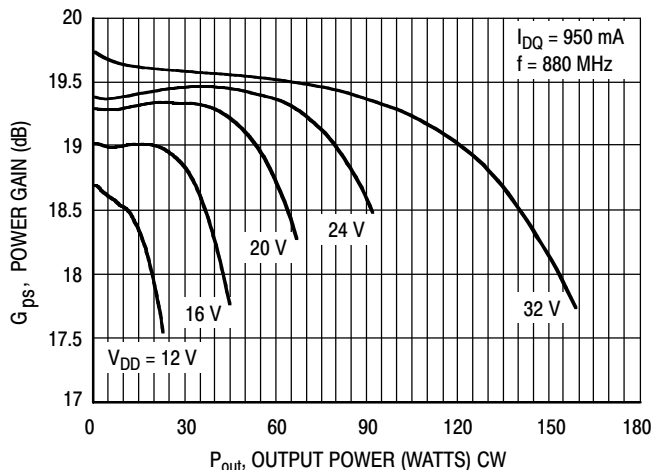
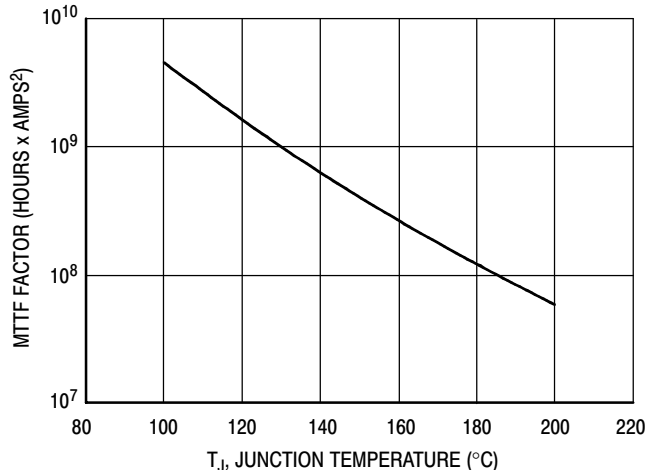
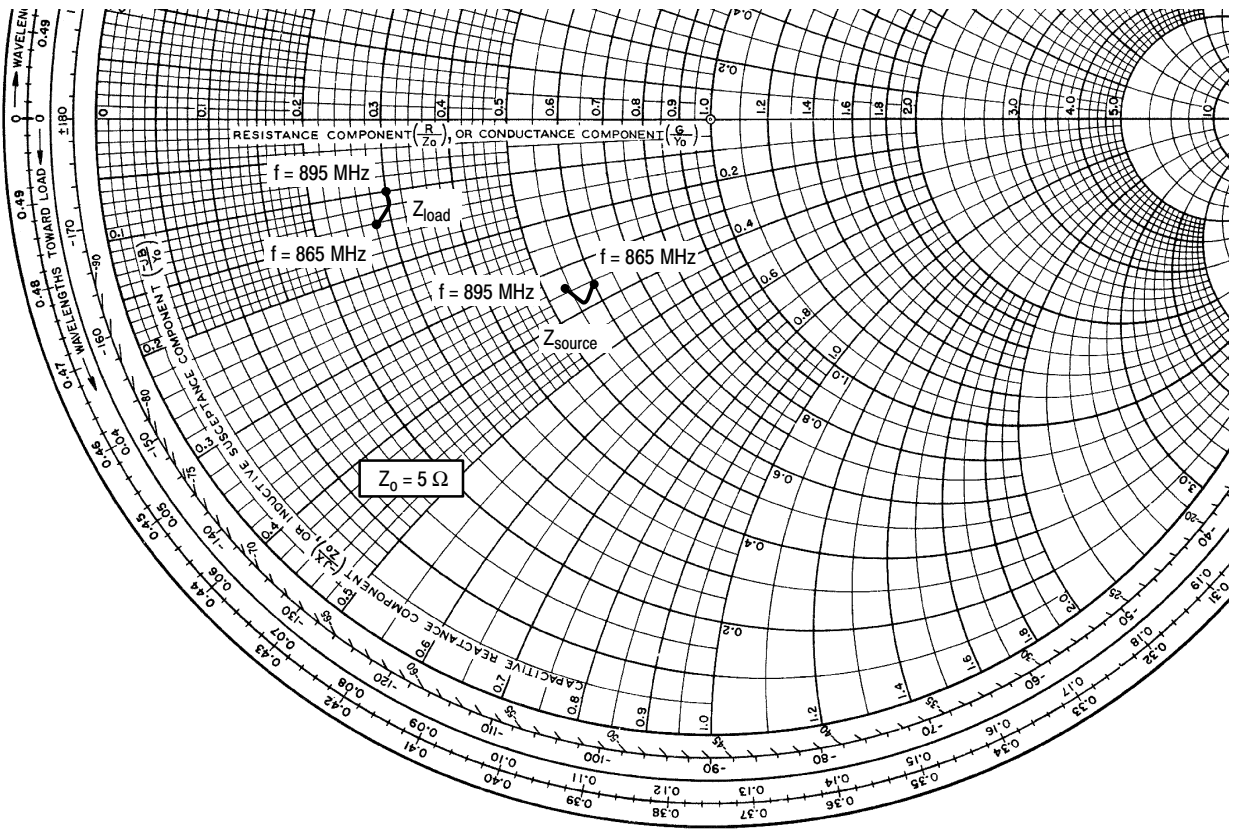


Figure 10. Power Gain versus Output Power



This above graph displays calculated MTTF in hours x ampere<sup>2</sup> drain current. Life tests at elevated temperatures have correlated to better than  $\pm 10\%$  of the theoretical prediction for metal failure. Divide MTTF factor by  $I_D^2$  for MTTF in a particular application.

Figure 11. MTTF Factor versus Junction Temperature



$V_{DD} = 26 \text{ Vdc}$ ,  $I_{DQ} = 950 \text{ mA}$ ,  $P_{out} = 20 \text{ W Avg.}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
865	$3.0 - j1.8$	$1.4 - j0.7$
880	$2.8 - j1.9$	$1.5 - j0.6$
895	$2.7 - j1.7$	$1.5 - j0.5$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

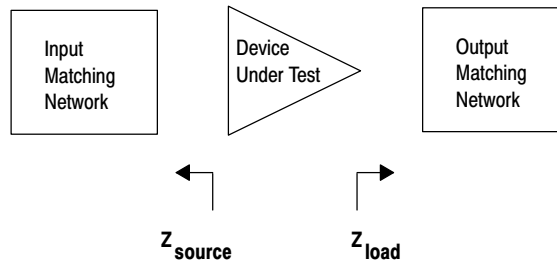
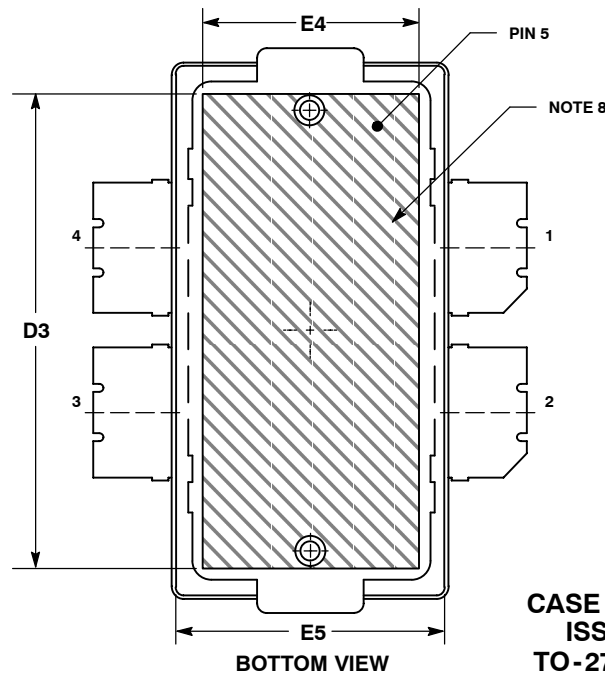
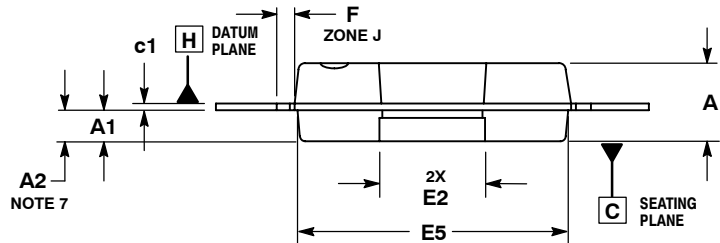
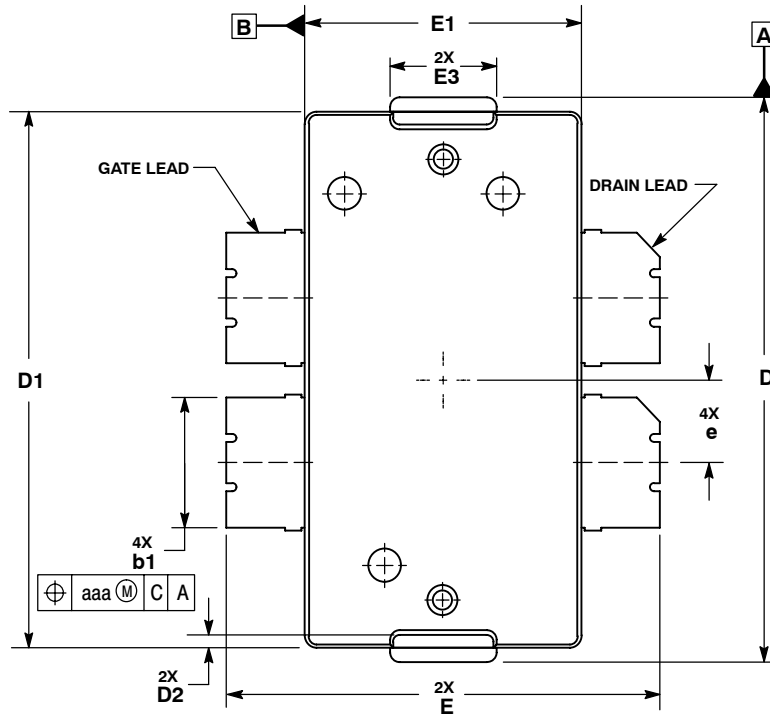


Figure 12. Series Equivalent Source and Load Impedance

# PACKAGE DIMENSIONS



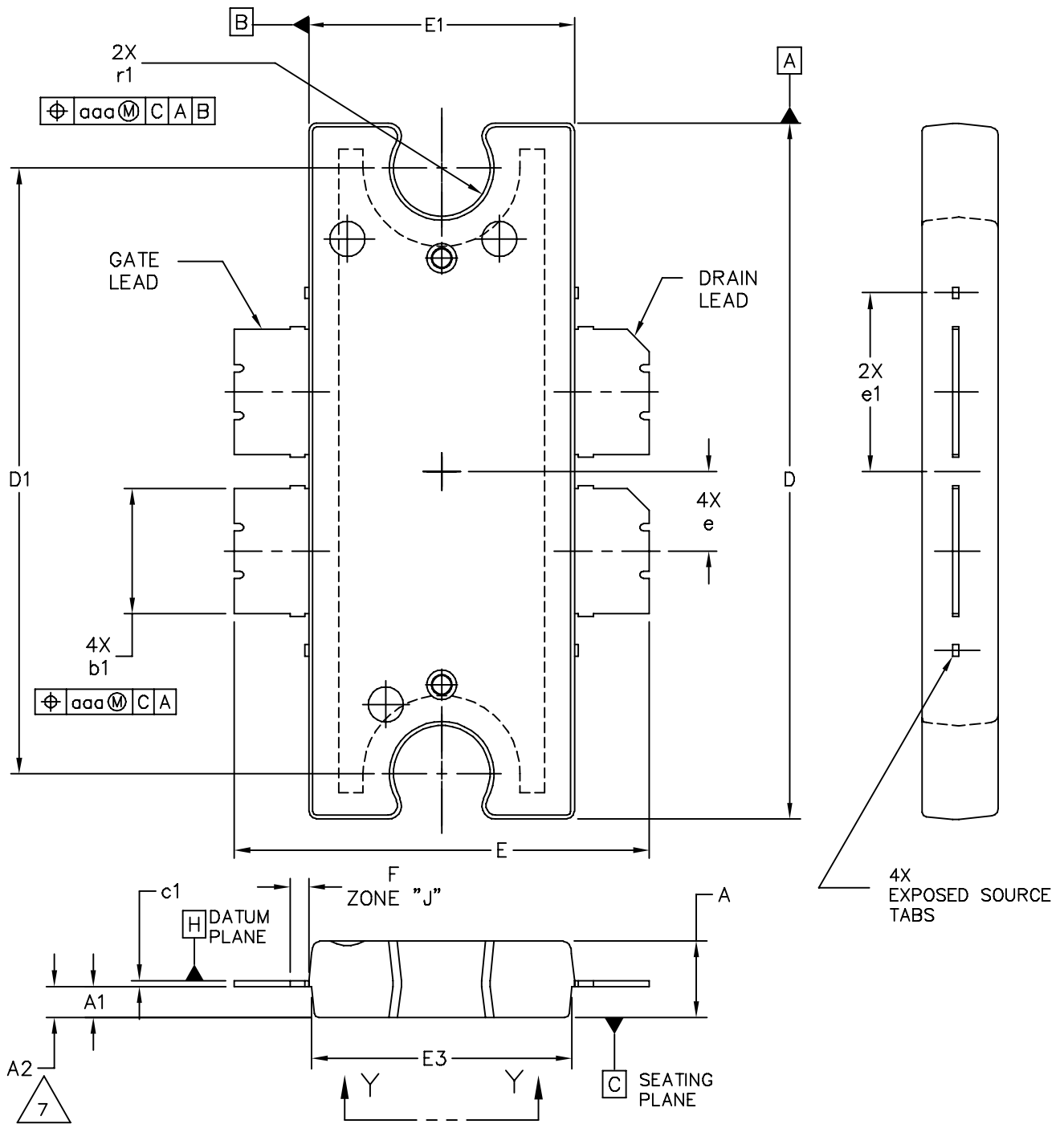
- NOTES:
1. CONTROLLING DIMENSION: INCH.
  2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
  3. DATUM PLANE -H- IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
  4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
  5. DIMENSION "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.
  6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
  7. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.
  8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64
A1	.039	.043	0.99	1.09
A2	.040	.042	1.02	1.07
D	.712	.720	18.08	18.29
D1	.688	.692	17.48	17.58
D2	.011	.019	0.28	0.48
D3	.600	---	15.24	---
E	.551	.559	14	14.2
E1	.353	.357	8.97	9.07
E2	.132	.140	3.35	3.56
E3	.124	.132	3.15	3.35
E4	.270	---	6.86	---
E5	.346	.350	8.79	8.89
F	.025 BSC		0.64 BSC	
b1	.164	.170	4.17	4.32
c1	.007	.011	0.18	0.28
e	.106 BSC		2.69 BSC	
aaa	.004		0.10	

- STYLE 1:  
 PIN 1. DRAIN  
 2. DRAIN  
 3. GATE  
 4. GATE  
 5. SOURCE

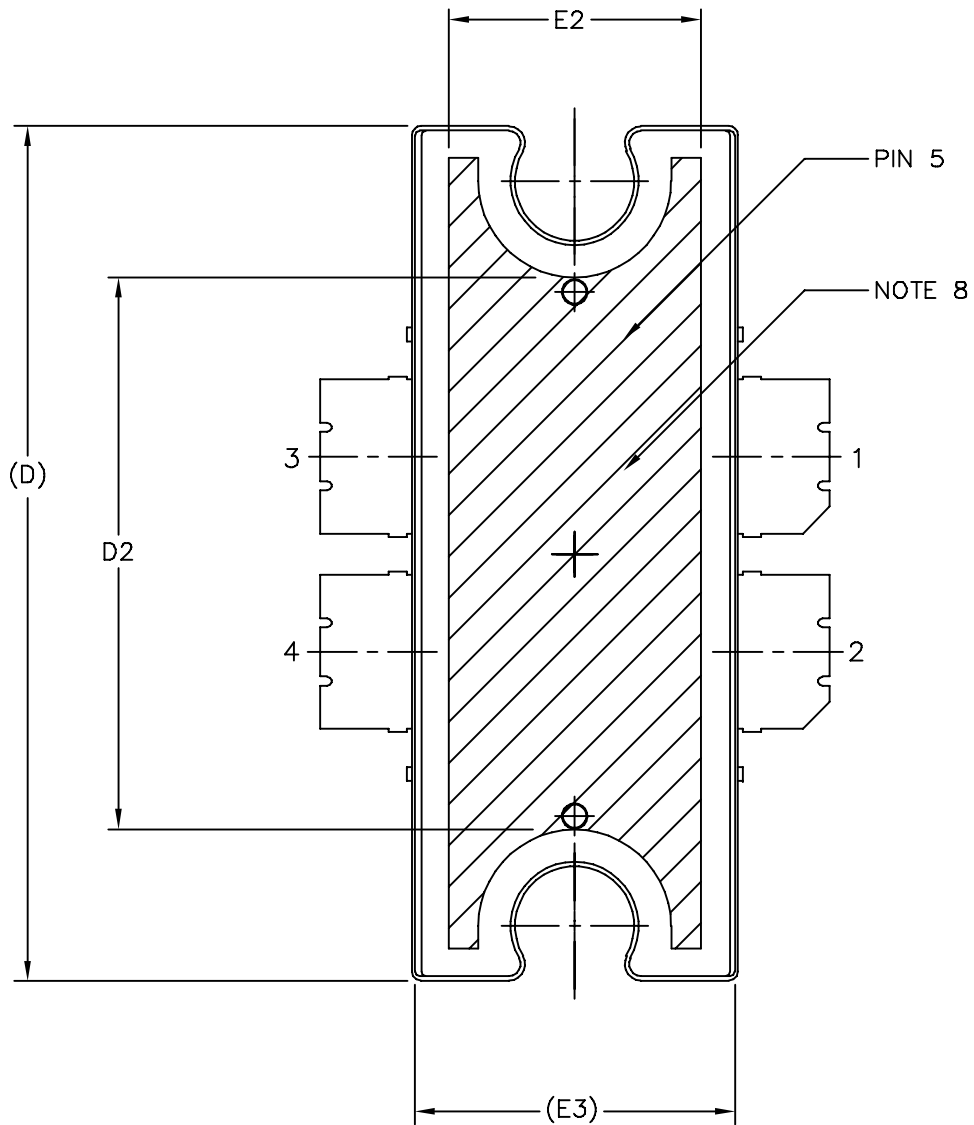
**CASE 1486-03  
 ISSUE C  
 TO-270 WB-4  
 PLASTIC  
 MRF5S9100MR1**





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	CASE NUMBER: 1484-04	05 APR 2006	
	STANDARD: NON-JEDEC		

MRF5S9100MR1 MRF5S9100MBR1



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	CASE NUMBER: 1484-04	05 APR 2006	
	STANDARD: NON-JEDEC		

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE H IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSIONS "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.
7. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.
8. HATCHING REPRESENTS EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

STYLE 1:

PIN 1 - DRAIN      PIN 2 - DRAIN  
 PIN 3 - GATE      PIN 4 - GATE  
 PIN 5 - SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64	b1	.164	.170	4.17	4.32
A1	.039	.043	0.99	1.09	c1	.007	.011	.18	.28
A2	.040	.042	1.02	1.07	r1	.063	.068	1.60	1.73
D	.928	.932	23.57	23.67	e	.106 BSC		2.69 BSC	
D1	.810 BSC		20.57 BSC		e1	.239 INFO ONLY		6.07 INFO ONLY	
D2	.600	---	15.24	---	aaa	.004		.10	
E	.551	.559	14	14.2					
E1	.353	.357	8.97	9.07					
E2	.270	---	6.86	---					
E3	.346	.350	8.79	8.89					
F	.025 BSC		0.64 BSC						

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			CASE NUMBER: 1484-04		05 APR 2006
			STANDARD: NON-JEDEC		

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